

Notice of References Cited

Application/Control No.

09/628,126

Applicant(s)/Patent Under
Reexamination
GOODWIN ET AL.

Examiner

Sheela J Huff

Art Unit

1642

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5866372	02-1999	Stein et al	435/69.3
	B	US-			
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	E	US-			
	F	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	4200043	05-1993	DE	Stein et al	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Skolnick et al, TIBTECH vol. 18 p. 34 (2000)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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